

# MP4209

High Power, High Speed Switching Applications  
 For Printer Head Pin Driver and Pulse Motor Driver  
 For Solenoid Driver

- 4-V gate drivability
- Small package by full molding (SIP 10 pins)
- High drain power dissipation (4-device operation)  
 : P<sub>T</sub> = 4 W (T<sub>a</sub> = 25°C)
- Low drain-source ON resistance: R<sub>DS (ON)</sub> = 0.28 Ω (typ.)
- High forward transfer admittance: |Y<sub>fs</sub>| = 3.5 S (typ.)
- Low leakage current: I<sub>GSS</sub> = ±10 μA (max) (V<sub>GS</sub> = ±16 V)  
 I<sub>DSS</sub> = 100 μA (max) (V<sub>DS</sub> = 100 V)
- Enhancement-mode: V<sub>th</sub> = 0.8 to 2.0 V (V<sub>DS</sub> = 10 V, I<sub>D</sub> = 1 mA)

### Absolute Maximum Ratings (T<sub>a</sub> = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V <sub>DSS</sub>	100	V
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		V <sub>DGR</sub>	100	V
Gate-source voltage		V <sub>GSS</sub>	±20	V
Drain current	DC	I <sub>D</sub>	3	A
	Pulse	I <sub>DP</sub>	12	
Drain power dissipation (1-device operation, T <sub>a</sub> = 25°C)		P <sub>D</sub>	2.0	W
Drain power dissipation (4device operation, T <sub>a</sub> = 25°C)		P <sub>DT</sub>	4.0	W
Single pulse avalanche energy (Note 1)		E <sub>AS</sub>	140	mJ
Avalanche current		I <sub>AR</sub>	3	A
Repetitive avalanche energy (Note 2)	- device operation	E <sub>AR</sub>	0.2	mJ
	4device operation	E <sub>ART</sub>	0.4	
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature range		T <sub>stg</sub>	-55 to 150	°C

Note 1: Condition for avalanche energy (single pulse) measurement  
 V<sub>DD</sub> = 50 V, starting T<sub>ch</sub> = 25°C, L = 20 mH, R<sub>G</sub> = 25 Ω, I<sub>AR</sub> = 3 A

Note 2: Repetitive rating; pulse width limited by maximum channel temperature

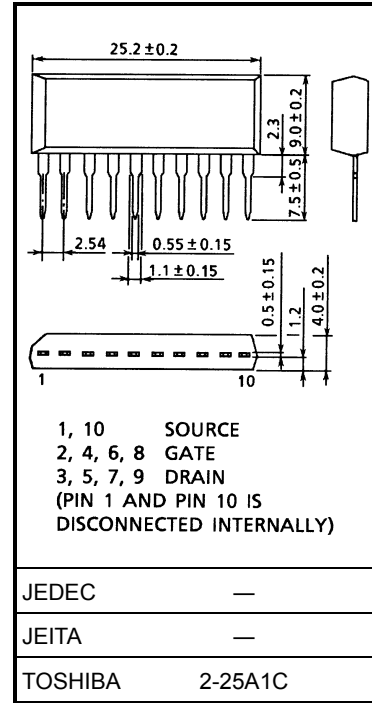
Note 3: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Please handle with caution.

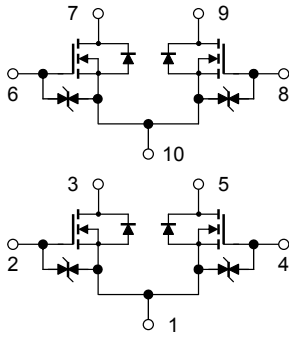
Industrial Applications

Unit: mm



Weight: 2.1 g (typ.)

## Array Configuration



## Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance from channel to ambient (4-device operation, $T_a = 25^\circ\text{C}$ )	$\Sigma R_{th}(\text{ch-a})$	31.2	$^\circ\text{C/W}$
Maximum lead temperature for soldering purposes (3.2 mm from case for $t = 10\text{ s}$ )	$T_L$	260	$^\circ\text{C}$

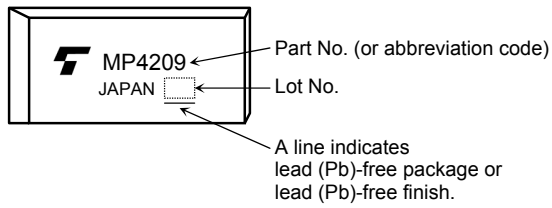
## Electrical Characteristics ( $T_a = 25^\circ\text{C}$ )

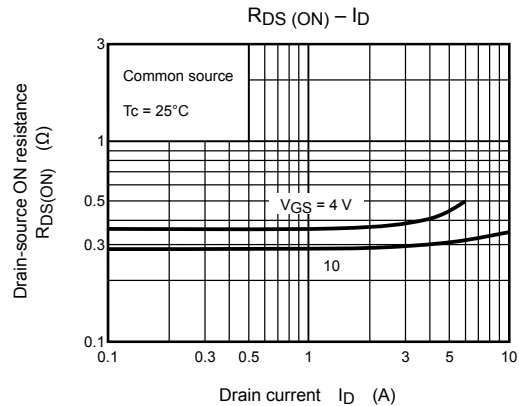
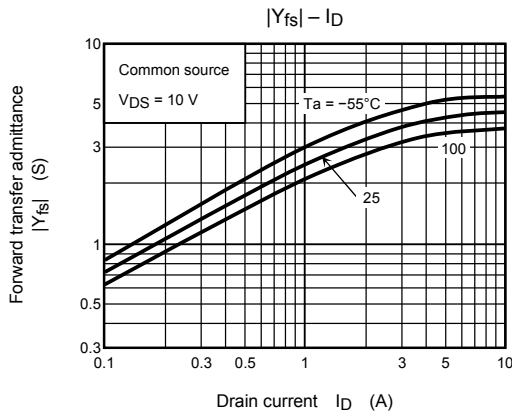
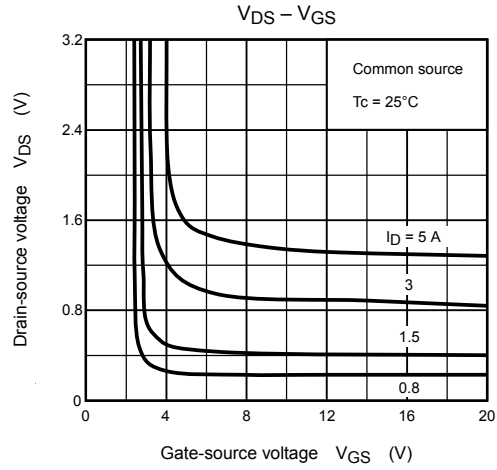
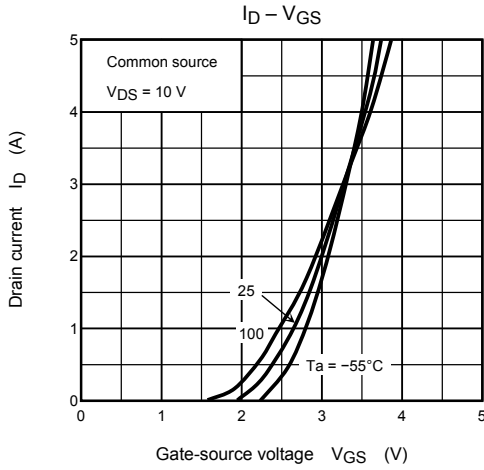
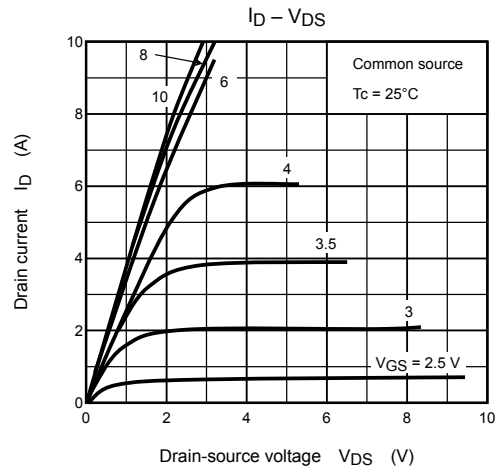
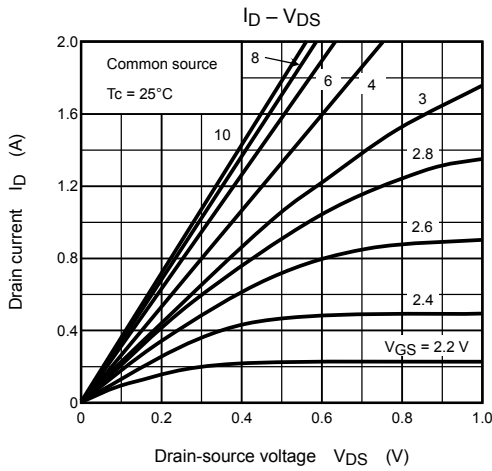
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		$I_{GSS}$	$V_{GS} = \pm 16\text{ V}, V_{DS} = 0\text{ V}$	—	—	$\pm 10$	$\mu\text{A}$
Drain cut-off current		$I_{DSS}$	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}$	—	—	100	$\mu\text{A}$
Drain-source breakdown voltage		$V(\text{BR})_{DSS}$	$I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$	100	—	—	V
Gate threshold voltage		$V_{th}$	$V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$	0.8	—	2.0	V
Drain-source ON resistance		$R_{DS(\text{ON})}$	$V_{GS} = 4\text{ V}, I_D = 2\text{ A}$	—	0.36	0.45	$\Omega$
			$V_{GS} = 10\text{ V}, I_D = 2\text{ A}$	—	0.28	0.35	
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10\text{ V}, I_D = 2\text{ A}$	1.5	3.5	—	S
Input capacitance		$C_{iss}$	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$	—	280	—	pF
Reverse transfer capacitance		$C_{rss}$		—	50	—	pF
Output capacitance		$C_{oss}$		—	105	—	pF
Switching time	Rise time	$t_r$		—	20	—	ns
	Turn-on time	$t_{on}$		—	50	—	
	Fall time	$t_f$		—	40	—	
	Turn-off time	$t_{off}$		—	170	—	
Total gate charge (gate-source plus gate-drain)		$Q_g$	$V_{DD} \approx 80\text{ V}, V_{GS} = 10\text{ V}$	—	13.5	—	nC
Gate-source charge		$Q_{gs}$	$I_D = 3\text{ A}$	—	8.5	—	nC
Gate-drain ("miller") charge		$Q_{gd}$		—	5	—	nC

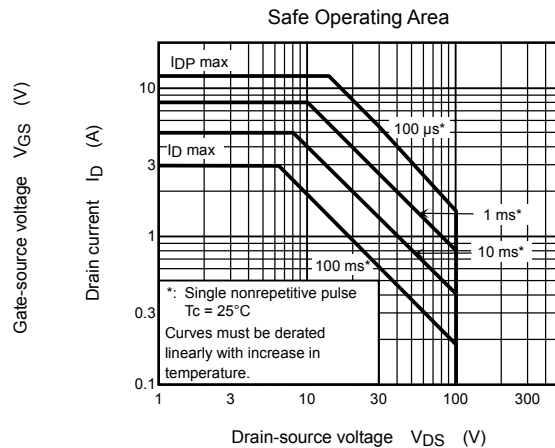
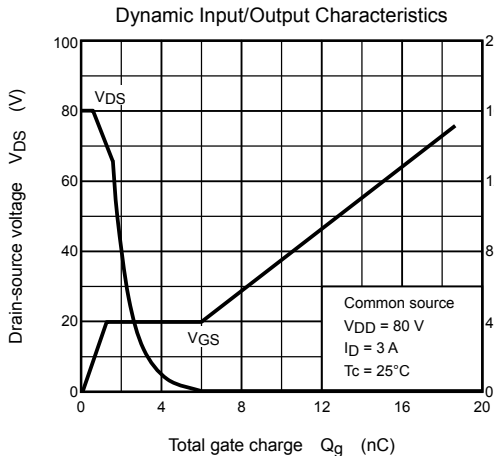
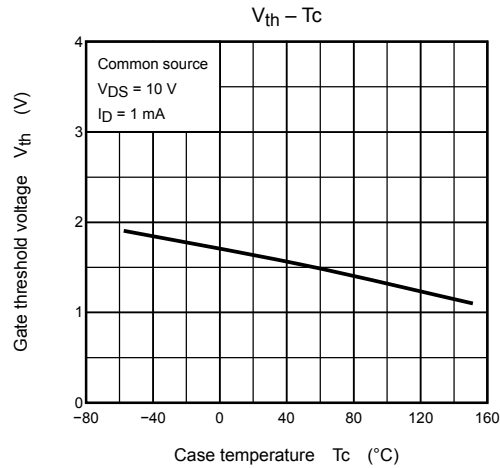
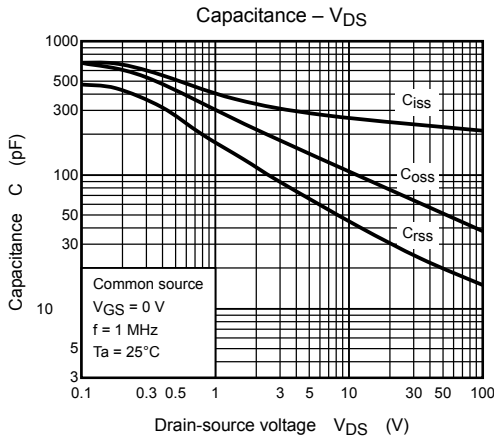
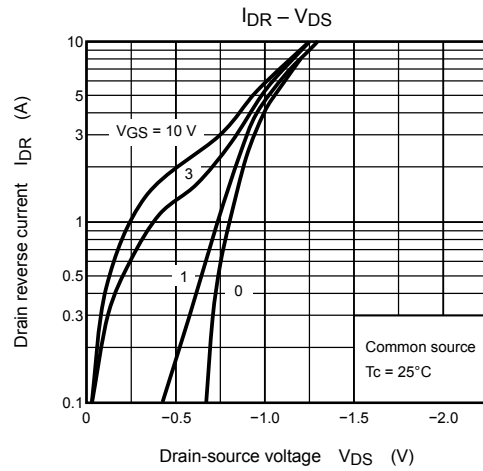
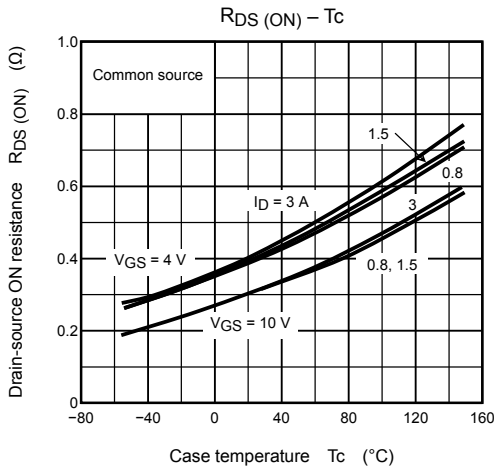
## Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

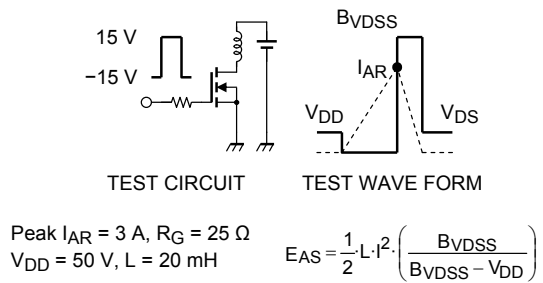
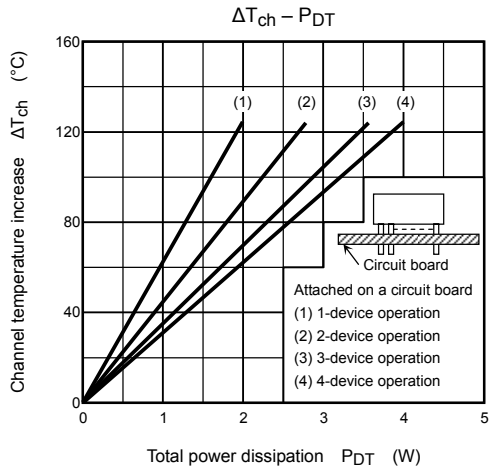
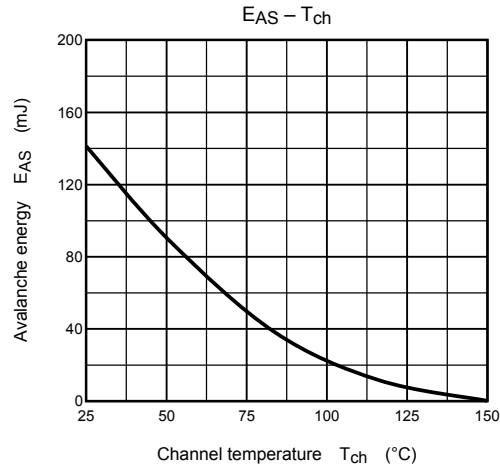
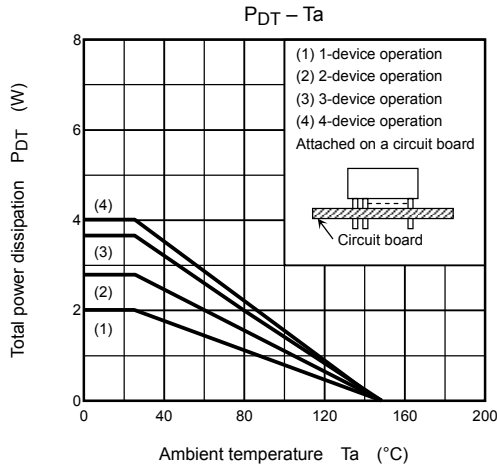
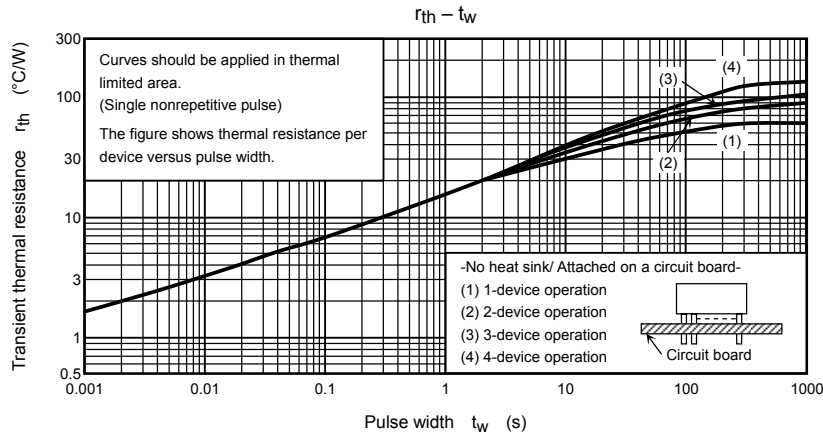
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current	$I_{DR}$	—	—	—	3	A
Pulse drain reverse current	$I_{DRP}$	—	—	—	12	A
Diode forward voltage	$V_{DSF}$	$I_{DR} = 3\text{ A}, V_{GS} = 0\text{ V}$	—	—	-1.5	V
Reverse recovery time	$t_{rr}$	$I_{DR} = 3\text{ A}, V_{GS} = 0\text{ V}$	—	100	—	ns
Reverse recovery charge	$Q_{rr}$	$dI_{DR}/dt = 50\text{ A}/\mu\text{s}$	—	0.2	—	$\mu\text{C}$

## Marking









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